

### Data Sheet- EddyCus® TF map 2530SR-A

#### P\_T\_2530\_11



# Highlights

- Contact-free imaging
- High resolution imaging (25 to 1,000,000 points)
- Integrity and defect imaging
- Mapping of encapsulated layers

## Applications

- Semiconductors
- Photovoltaics
- Touch panel sensors
- Displays and lighting
- Batteries, capacitors, fuel cells
- De-icing and heating
- Smart-glass and LowE
- WLP, PCB
- Packaging materials
- Antistatic

#### Processes

- Deposition (PVD, evaporation, plating, CVD, ALD ...)
- Layer and material modification (implantation, doping, annealing)
- Layer removal (CMP, etching, scribing ...)

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Made and Engineered in Germany

Innovation Award by Free State of Saxony 2013 1<sup>st</sup> Place



## Materials

- Semiconductors (Si, SiC, GaAs ...)
- Metals
- ▶ Graphene, CNT, graphite
- Conductive oxides and nitrides
- Mesh and nanowire films
- ► Conductive inks, polymers (PEDOT)
- Other conductive films



Measurement technology	Non-contact eddy current sensor
Substrates	Foils, glass etc. ≥ 100 mm x 100 mm
Max. scanning area	12 inch / 300 mm x 300 mm (larger on request)
Edge effect correction / exclusion	2 – 10 mm (depending on size, measurement range and requirements)
Max. sample thickness / sensor gap	2/5/10/25 mm (defined by the thickest sample / application)
Sheet resistance range accuracy can be optimized over sheet resistance decade within a customer specified range	0.001 – 10 Ohm/sq; 2 to 7 % accuracy 0.01 – 1,000 Ohm/sq; 2 to 7 % accuracy 10 – 3,000 Ohm/sq; 2 to 7 % accuracy
Anisotropy range	0.33 – 3 (0.1 – 10 on request)
Thickness measurement of metal films (e.g. copper)	2 nm – 2 mm (in accordance with sheet resistance)
Scanning pitch	1 / 2.5 / 5 / 10 / 25 mm (other on request)
Measurement points per time (quadratic shape)	10,000 measurement points in 5 minutes 1,000,000 measurement points in 30 minutes
Scanning time	8 inch / 200 mm x 200 mm in 1.5 to 15 minutes (1 – 10 mm pitch) 12 inch / 300 mm x 300 mm in 2 to 15 minutes ( 2.5 – 25 mm pitch)
Device dimension (w /h /d) / weight	31.5 x 19.1 x 33.5 inch / 799 x 486 x 850 mm / 90 kg

#### Software and Handling - Sheet Resistance Analyzer 2.0

